Product Information

The ULTRAObjective

Resolution down to the Nanometer

Do you use optical methods for surface analysis and often wish for a higher resolution - 50,000 times or even greater than 500,000 times? Or maybe you want to perform quantitative structural measurements? The ULTRAObjective is the ideal partner for your optical microscope. The measuring head, whose size, shape and mounting take up the same space as a normal optical objective, is a complete atomic force microscope. Enter the fascinating world of the nanosphere with your microscope in the blink of an eye. The ULTRAObjective fits into the nosepiece of your microscope just like an optical objective. It can be adapted to fit all common types of microscopes (Zeiss, Leica, Nikon, Olympus). Simply choose an interesting area of the sample with the optical microscopy method you already use, and then swivel in the ULTRAObjective for a direct examination with the SPM. Within minutes, you will receive a high-resolution image which can be further evaluated with analySIS, the powerful image analysis software available with the SCANControl C electronics.

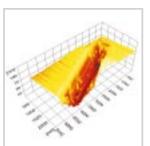


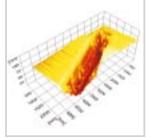
SURFACE IMAGING SYSTEMS

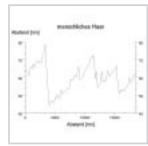


Top left: ULTRAObjective mounted on a Zeiss microscope Top right: ULTRAObjective mounted on an Olympus microscope









Measuring modes

The ULTRAObjective offers maximum versatility. All AFM/SPM measuring modes can be used. The measuring head can be easily changed for new applications. The following standard measuring modes are available: contact, non-contact mode, phase contrast, field contrast for magnetic or electrical characterisations (MFM/EFM), force modulation (FM), lateral force (LFM), fluid compatibility, and metrology-compatible measuring head with sensor. Other modes available on request.

Far left: Detail from the illustration above Left: 3D image of a scratch on a lense, measured in the non-contact mode

Applications

The *ULTRA*Objective can be used to inspect all biological or inorganic surfaces. The ULTRAObjective liquid immersion can even be used in fluids.

Far left: 2D image of a human hair, measured in non-contact mode with ULTRAObjective mounted on a Zeiss microscope

Left: Cross-section through the image to the left

Specifications of the *ULTRA*Objective-SPM-System

adjustment free Tip change: Scan range: 20 μm x 20 μm x 3 μm 40 μm x 40 μm x 4 μm Digital input resolution: 16 bit A/D 80 μm x 80 μm x 5 μm hardware linearized scan Digital output resolution: 16 bit D/A motion in X-Y-direction Output voltage: \pm 165 V, with 2 μV rms (optional in Z-direction) Input channels: max. 4 simultaneous < 1 nm rms in vertical direction (Z), Noise level: depending on microscope External inputs: max. 3 high speed with 16 bit resolution Lateral accuracy: typically within 1%, closed loop scanning freely selectable, from 128 to Image size: 1024 pixels, even rectangular sizes Scan speed: typ. 1 to 10 Hz Processing: internal 32 bit DSP, typ. 50 MHz Detection principle: fiber optic interferometry, noise level < 0,01 nm rms Computer interface: USB (standard universal serial bus) Tips: silicon tips, various types Operating system: MS-Windows 2000®